

# Making the Grade Choosing the Right CCD Camera Chip Grade

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## Introduction

Today, charge coupled devices (CCDs) have become the de-facto standard for scientific imaging. In fact, their potential for high resolution, sensitivity, wide dynamic range and low noise has made them the device of choice for most fluorescent microscopy imaging applications. This is especially true for quantitative microscopy applications such as ratio imaging, fluorescent in-situ hybridization and image deconvolution.

However, choosing the most appropriate CCD camera for each application can be quite challenging given the broad range of features and performance specifications. This month's article focuses on a single characteristic of the CCD: the chip grade.

The grade of a CCD sensor is, unfortunately, one of its least discussed characteristics. Often, manufacturers and salespeople avoid talking about chip grade as they see it as a measure of how far a chip is from perfection. Hence, to discuss chip grade implies camera defects. Defects that can lead to black or white spots or even lines across the image! For camera vendors, it is a sore point because they know their users would be most satisfied if they could provide perfect chips to everyone. Likewise, it is a point of contention for users who feel that camera vendors are somehow passing off defective merchandise. Fortunately, the solution is simple: be an educated consumer and choose the most appropriate chip grade for one's primary applications.

## Why Aren't All Chips Perfect?

Charged Coupled Devices are large semiconductor devices, created in the same manner as other integrated circuits. Just a few years ago, it was considered an amazing feat when engineers fabricated the first million-transistor chip. Amazing, because such a chip contains so many elements that the probability for errors to arise became close to 100%.

In smaller chips with fewer elements, this is not such a problem for a number of reasons. First, one can produce small chips in very large quantities, allowing one to discard defects. In the semiconductor business, the ratio of good chips to defects is called the "chip yield". However, as chip size increases, the yield decreases dramatically. Hence large chips without defects are quite rare and therefore they are very expensive to produce.

Imagine the added difficulty of creating a "perfect" CCD array. Each pixel on a CCD is an individual area of the chip that is sensitive to light. If any pixel has a different response from its neighbors, it will read a different value. In normal computer chips, slight variations of this sort are acceptable because digital circuits accept a wide range of values as either "on" or "off". CCDs are quite different. Research grade cameras might be used to measure changes of only a few percent, hence a pixel that has a twenty percent deviation from the average would typically be considered defective.

To summarize - defects are inevitable in the current semiconductor manufacturing process. The larger the device, the more likely it is to have defects.

## Why Sell Defective Chips?

As noted, chip yield results in high prices for near perfect chips. Camera manufacturers could choose to sell only cameras with perfect chips, but these might cost more than most users could afford. Hence they sell "imperfect" chips at a discount. This seems a rational decision, as the defects are often minor: a handful of random pixels might be abnormal or perhaps a column or two might be "dead". In addition, many of the problems can be fixed via software. The result is that one can now purchase cameras using large, high resolution CCDs much more affordably than would be otherwise possible.

## What Types of Defects Exist?

There are a small variety of defect types that a chip may have. These include point, column or cluster defects and hot, dark or dead pixels.

Point defects are the most benign type of chip defect. A small number of pixels that do not respond exactly the same as their neighbors poses little threat to accurate quantitation as they can be ignored or replaced based on their neighbors' values using a simple algorithm.

Point defects fall into the following sub-categories:

Dead pixels - (Figure 1) pixels that are totally non-responsive resulting in pixels that always read some constant value.

Dark pixels - these are pixels that are less sensitive than they should be and hence return a low value.

Hot pixels - (Figure 2) pixels that build up charge faster than they should, resulting in bright spots on the image.

Column defects (Figure 3) are typically entire columns of dead pixels. These are problematic, as they are visually distracting and are more difficult to remove than isolated pixel defects.

Cluster defects consist of more than one adjacent pixel containing defects. I've never seen cluster defects, and camera people only talk about them in literature. Therefore they're not included in the chip-grading list below, but clusters would be put in a better grade than line defects, perhaps grade 1 if there were a cluster or two. A handful of clusters might be considered as objectionable as one line defect. Unfortunately, manufacturers don't even seem to talk about cluster defects in their ratings!

The following list is a guide to the grades used by chip manufacturers to specify the kinds of defects that are allowable on a chip. By reviewing this and the accompanying pictures, you can gain an understanding of what to expect from a given camera chip grade. Note that different manufacturers may grade chips differently.

Grade 0: Perfect, as in zero defects. A perfect chip.

Grade 1: This chip may contain a small number of point defects but may not contain any column defects.

Grade 2: One or "a few" column defects and/or many point defects.

Grade 3: Many point and column defects

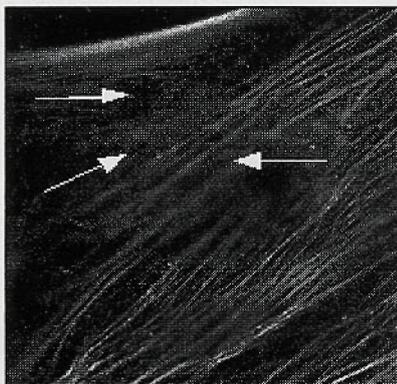


Figure 1: Dead pixels

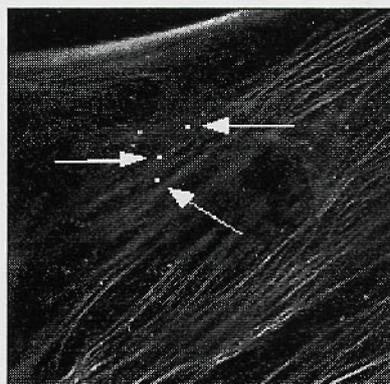


Figure 2: hot Pixels

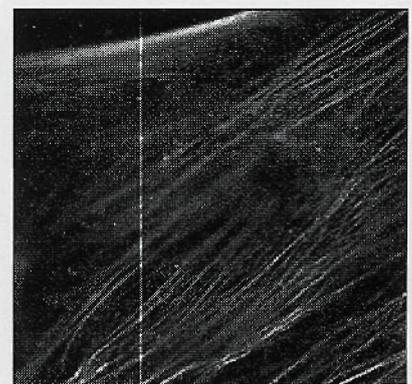


Figure 3: Column defect

### Discussion

The previous list roughly defines the chip grades, outlining basic chip defects that one can expect. Unfortunately, the manufacturers have chosen not to standardize their chip grading criteria, resulting in great confusion for consumers. Today, one manufacturer's grade 1 chip may be considerably different from another's, making it important to learn from the vendor exactly how they grade each chip.

Fortunately, chip quality is steadily improving, and the currently popular Sony interline transfer chips are rated by Sony as "perfect". So perhaps within the next few years, all cameras will give picture perfect results every time. But for now, look carefully and understand completely exactly what is being purchased. ■

### References:

Cosmetic Grading for Kodak Sensors:

[http://www.apogee-ccd.com/kodak\\_cosmetic.html](http://www.apogee-ccd.com/kodak_cosmetic.html)

Cosmetic Grading for SITe Sensors:

[http://www.apogee-ccd.com/site\\_cosmetic.html](http://www.apogee-ccd.com/site_cosmetic.html)

Selection of CCD Arrays:

<http://www.prinst.com/pdfs/pg15.pdf>

Application of Stack Filter in CMOS Imager Whitespot Compensation:

<http://yake.ecn.purdue.edu/~jrjen/Application/cmos.html>

For a large number of WWW references to specific chip grading practices of the manufacturers, please see the VideoMicroscopy Web site:

<http://www.videomicroscopy.com/Tutorials/CCD%20Grading/CCD%20grades.htm>

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